

<b>Notice of References Cited</b>	Application/Control No. 10/770,723	Applicant(s)/Patent Under Reexamination TANAKA ET AL.	
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**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	A	US-2003/0191891	10-2003	Tanaka et al.	711/114
	B	US-2003/0110254	06-2003	Fujita et al.	709/224
	C	US-			
	D	US-			
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**FOREIGN PATENT DOCUMENTS**

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